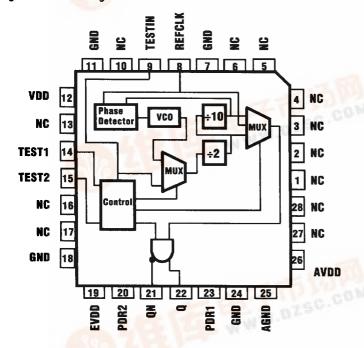


Figure 1. Pinout Diagram



TriQuint's TQ2059 is a high-frequency clock generator. It utilizes a 20 MHz to 35 MHz TTL input to generate a 200 MHz to 350 MHz PECL output. The TQ2059 has a completely self-contained Phase-Locked Loop (PLL) running at 400 MHz to 700 MHz. This stable PLL allows for a low period-to-period output jitter of 120 ps (max), and enables tight duty-cycle control of 55% to 45% (worst case).

The TQ2059 provides optional 200-ohm on-chip pull-down resistors which are useful if the output is AC-coupled to the device being driven. In order to use these resistors, pin 20 (PDR2) should be connected to pin 21 (QN), and pin 23 (PDR1) should be connected to pin 22 (Q).

Various test modes on the chip simplify debug and testing of systems by slowing the clock output or by bypassing the PLL.



High-Frequency Clock Generator

Features

- Output frequency range: 200 MHz to 350 MHz
- One differential PECL output: 600 mV (min) swing
- Common-mode voltage:
 V_{DD} -1.2 V (max),
 V_{DD} -1.6 V (min)
- Period-to-period output jitter:
 30 ps peak-to-peak (typ)
 120 ps peak-to-peak (max)
- Reference clock input: 20 MHz to 35 MHz TTL-level crystal oscillator
- · Self-contained loop filter
- Optional 200-ohm pull-down resistors for AC-coupled outputs
- +5 V power supply
- 28-pin J-lead surface-mount package
- Ideal for designs based on DEC Alpha AXP[™] processors



TQ2059

Figure 2. Simplified Block Diagram

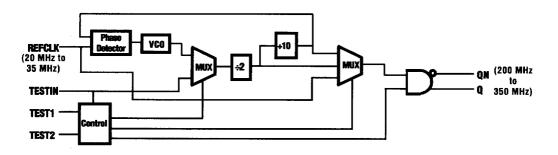


Table 1. Mode Selection

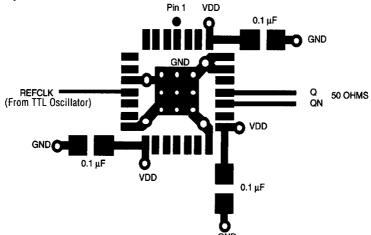
Mode	TEST1	TEST2	TESTIN 1	REFCLK ²	Q, QN
1 (Test)	0	0	f _{TESTCLK}	"don't care"	f _{TESTCLK} ÷ 20
2 (Test)	0	1	"don't care"	"don't care"	0, 1
3 (Test)	1	0	f _{TESTCLK}	"don't care"	f _{TESTCLK} ÷ 2
4 (Bypass)	1 .	1	0	f _{REFCLK}	f _{REFCLK}
5 (Normal)	1	1	1	f _{REFCLK}	10 x f _{REFCLK} 3

Note: 1. In modes 1 and 3, TESTIN may be used to bypass the PLL. A clock input at TESTIN will be divided as shown.

2. REFCLK = 20 MHz to 35 MHz. 3. Q, QN = 200 MHz to 350 MHz.

Recommended Layout

(Not to scale)



■ 8706218 0002888 **■**



Absolute Maximum Ratings

Storage Temperature	-65°C to +150°C
Ambient temperature with power applied	-55°C to +110°C
Supply voltage to ground potential	−0.5 V to +7.0 V
DC input voltage	-0.5 V to (V _{DD} + 0.5) V
DC input current	-30 mA to +5 mA
Package thermal resistance (MQuad)	θ _{JA} = 45°C/W
Die junction temperature	T _J = 150°C

Note: Stresses above those listed in Absolute Maximum Ratings may cause permanent damage to the device.

The device should be operated only under the DC and AC conditions shown below.

DC Characteristics ($V_{DD} = +5 \text{ V } \pm 5\%$, $T_A = 0 \text{ °C to } +70 \text{ °C})^1$

Symbol	Description	Test Conditions	Min	Limits ¹ Typ	Max	Unit
V _{OH}	Output HIGH voltage	V _{CC} = Min PECL load	V _{CC} -1.20		V _{CC} 0.50	٧
V _{OL}	Output LOW voltage	V _{CC} = Min PECL load	V _{CC} -2.00		V _{CC} -1.60	٧
V _{CMO}	Output common mode voltage	PECL	V _{CC} -1.60		V _{CC} -1.20	V
V _{OUT}	Output differential voltage	PECL	0.6		1.2	٧
V _{IH} ²	Input HIGH level	Guaranteed input logical HIGH Voltage for all inputs	2.0			٧
V _{IL} ²	Input LOW level	Guaranteed input logical LOW Voltage for all inputs		2000	0.8	٧
I _{IL}	Input LOW current	$V_{DD} = Max$ $V_{IN} = 0.40 V$		-150	-400	μΑ
l _{IH}	Input HIGH current	$V_{DD} = Max$ $V_{IN} = 2.7 V$		0	25	μA
l _i	Input HIGH current	$V_{DD} = Max$ $V_{IN} = 5.3 V$		2	1000	μA
I _{DDS} 3	Power supply current	V _{DD} = Max		85	120	mA
Vi	Input clamp voltage	V _{DD} = Min I _{IN} = -18 mA		-0.70	-1.2	٧

Capacitance

Symbol	Description	Test Conditions	Min	Тур	Max	Unit
C_{1N}	Input Capacitance	V _{IN} = 2.0 V at f = 1 MHz		6		pF
C _{OUT}	Output Capacitance	V _{OUT} = 2.0 V at f = 1 MHz		9		pF

Notes: 1. Typical limits are at $V_{DD} = 5.0 \text{ V}$ and $T_A = 25^{\circ}\text{C}$.

- 2. These are absolute values with respect to device ground and include all overshoots due to system or tester noise.
- 3. This parameter is measured with device not switching and unloaded.



TQ2059

AC Characteristics ($V_{DD} = +5 \text{ V } \pm 5\%$, $T_A = 0 \text{ °C to } +70 \text{ °C}$)

Symbol	Input Clock (REFCLK)	Test Conditions	Min	Тур	Max	Unit
t _{CPWH}	CLK pulse width HIGH	Figure 2	4	_		ns
t _{CPWL}	CLK pulse width LOW	Figure 2	4		_	ns
t _{iR}	Input rise time		_	_	2.0	ns
	(0.8 V - 2.0 V)					

Symbol	Input Clock (REFCLK)	Test Conditions	Min	Тур	Max	Unit
t _{OR} , t _{OF}	Rise/fall time (20% - 80%)	Figure 2	100	220	350	ps
t _{CYC}	Duty-cycle	Figure 2	45	50	55	%
t _{JP} ²	Period-to-Period Jitter		_	30	120	ps
t _{SYNC} 3	Synchronization Time		-	10	500	μѕ

Notes: 1. All measurements are tested with a REFCLK having a rise time of 0.5 ns (0.8 V to 2.0 V).

- 2. Jitter specification is peak to peak. Period-to-Period jitter is the jitter on the output with respect to the output's previous crossing.
- 3. t_{SYNC} is the time required for the PLL to synchronize and assumes the presence of a CLK signal.

Figure 1

PECL Test Load

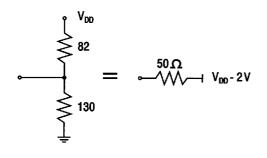
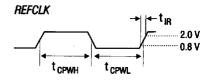
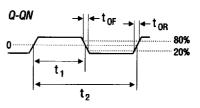


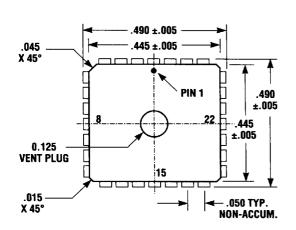
Figure 2

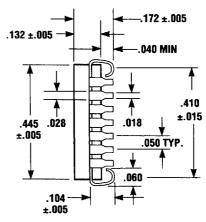




$$\frac{t_1}{t_2}$$
 X 100 = 55% to 45%

28-Pin MQuad J-Leaded Package Mechanical Specification (All dimensions in inches)





28-Pin MQuad Pin Description

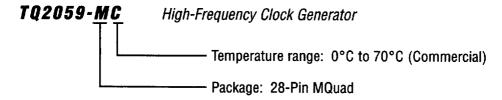
Pin #	Pin Name	Description	1/0
1	NC	No Connect	_
2	NC	No Connect	_
3	NC	No Connect	_
4	NC	No Connect	
5	NC	No Connect	
6	NC	No Connect	_
7	GND	Ground	_
8	REFCLK	Reference Clock	I
9	TESTIN	Test Input	ļ
10	NC	No Connect	
11	GND	Logic Ground	
12	VDD	Logic VDD (+5 V)	
13	NC	No Connect	
14	TEST1	Test Control 1	

Pin #	Pin Name	Description	1/0
15	TEST2	Test Control 2	1
16	NC	No Connect	
17	NC	No Connect	0
18	GND	Ground	_
19	EVDD	VDD for ECL Output (+5 V)	_
20	PDR2	Pull-down Resistor 2 (200 Ω)	ŀ
21	QN	Differential PECL Output (-)	0
22	Q	Differential PECL Output (+)	0
23	PDR1	Pull-down Resistor 1 (200 Ω)	1
24	GND	Ground	_
25	AGND	Analog Ground	
26	AVDD	Analog VDD (+5 V)	_
27	NC	No Connect	
28	NC	No Connect	_



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